VNQ5160K-E

Quad channel high side driver for automotive applications

Features

Max transient supply voltage	V_{CC}	41V
Operating voltage range	V_{CC}	4.5 to 36 V
Max on-state resistance (per ch.)	R_{ON}	160 mΩ
Current limitation (typ)	I_{LIMH}	5.4 A
Off-state supply current	I_S	2 μA[1]

1. Typical value with all loads connected

■ General features
  – Inrush current active management by power limitation
  – Very low standby current
  – 3.0 V CMOS compatible input
  – Optimized electromagnetic emission
  – Very low electromagnetic susceptibility
  – In compliance with the 2002/95/EC European directive

■ Diagnostic functions
  – Open drain status output
  – On-state open-load detection
  – Off-state open-load detection
  – Thermal shutdown indication

■ Protection
  – Undervoltage shutdown
  – Overvoltage clamp
  – Output stuck to V_{CC} detection
  – Load current limitation
  – Self limiting of fast thermal transients
  – Protection against loss of ground and loss of V_{CC}
  – Thermal shut down
  – Reverse battery protection (see *Application schematic on page 18*

PowerSSO-24

  – Electrostatic discharge protection

Applications

■ All types of resistive, inductive and capacitive loads

Description

The VNQ5160K-E is a monolithic device made using STMicroelectronics VIPower™ M0-5 technology. It is intended for driving resistive or inductive loads with one side connected to ground. Active V_{CC} pin voltage clamp protects the device against low energy spikes (see ISO7637 transient compatibility table).

The device detects open-load condition in both on and off states, when STAT_DIS is left open or driven low. Output shorted to V_{CC} is detected in the off-state. When STAT_DIS is driven high, the STATUS pin is in a high impedance condition.

Output current limitation protects the device in overload condition. In the case of long duration overload, the device limits the dissipated power to a safe level up to thermal shutdown intervention.

Thermal shutdown with automatic restart allows the device to recover normal operation as soon as a fault condition disappears.

Table 1. Device summary

Package	Order codes	
	Tube	Tape and reel
PowerSSO-24	VNQ5160K-E	VNQ5160KTR-E

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1 Block diagram and pin configuration

Figure 1.   **Block diagram**

Table 2.   **Pin functions**

Name	Function
V_{CC}	Battery connection
OUTPUTn	Power output
GND	Ground connection. Must be reverse battery protected by an external diode/resistor network
INPUTn	Voltage controlled input pin with hysteresis, CMOS compatible. Controls output switch state
STATUSn	Open drain digital diagnostic pin
STAT_DIS	Active high CMOS compatible pin, to disable the STATUS pin

Figure 2. Configuration diagram (top view)


```
         VCC  ⊏ 1      24 ⊐  OUTPUT1
         GND  ⊏ 2      23 ⊐  OUTPUT1
       INPUT1 ⊏ 3      22 ⊐  OUTPUT1
      STATUS1 ⊏ 4      21 ⊐  OUTPUT2
       INPUT2 ⊏ 5      20 ⊐  OUTPUT2
      STATUS2 ⊏ 6      19 ⊐  OUTPUT2
       INPUT3 ⊏ 7      18 ⊐  OUTPUT3
      STATUS3 ⊏ 8      17 ⊐  OUTPUT3
       INPUT4 ⊏ 9      16 ⊐  OUTPUT3
      STATUS4 ⊏ 10     15 ⊐  OUTPUT4
     STAT_DIS ⊏ 11     14 ⊐  OUTPUT4
         VCC  ⊏ 12     13 ⊐  OUTPUT4
```

TAB = V_{CC}
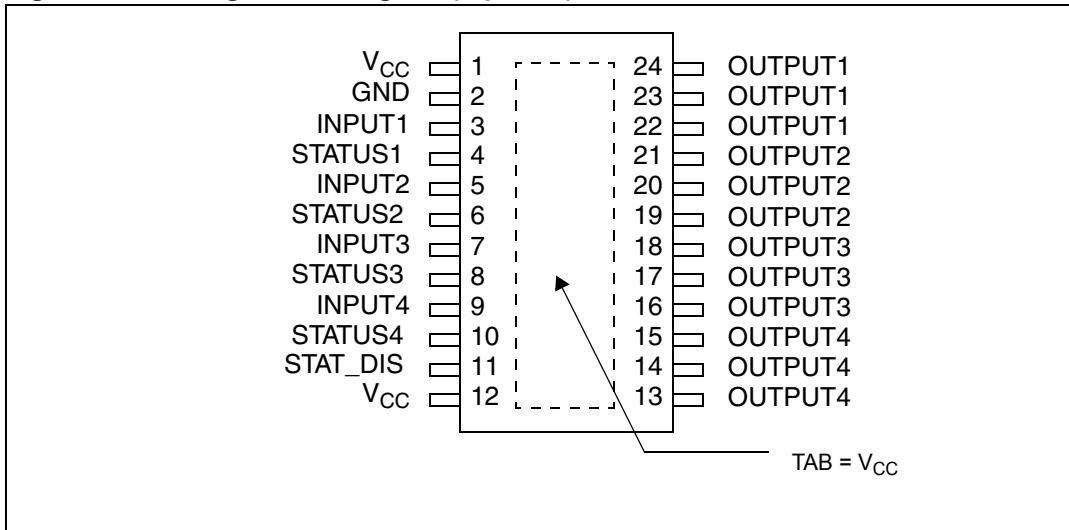
Table 3. Suggested connections for unused and not connected pins

Connection / Pin	Status	N.C.	Output	Input	STAT_DIS
Floating	X	X	X	X	X
To ground	N.R.[(1)]	X	N.R.	Through 10 kΩ resistor	Through 10 kΩ resistor

1. Not recommended

2 Electrical specifications

Figure 3. Current and voltage conventions
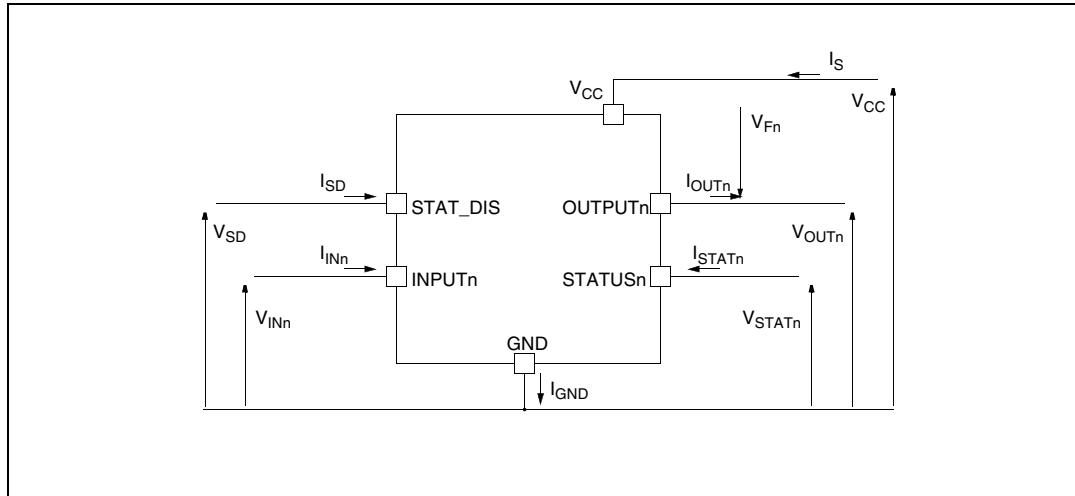
Note: $V_{Fn} = V_{OUTn} - V_{CCn}$ during reverse battery condition

2.1 Absolute maximum ratings

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CC}	DC supply voltage	41	V
$- V_{CC}$	Reverse DC supply voltage	0.3	V
$- I_{GND}$	DC reverse ground pin current	200	mA
I_{OUT}	DC output current	Internally limited	A
$- I_{OUT}$	Reverse DC output current	6	A
I_{IN}	DC input current	+10 / -1	mA
I_{STAT}	DC status current	+10 / -1	mA
I_{STAT_DIS}	DC status disable current	+10 / -1	mA
E_{MAX}	Maximum switching energy (single pulse) (L=12mH; R_L=0Ω; V_{bat}=13.5V; T_{jstart}=150ºC; $I_{OUT} = I_{limL}$(Typ.))	33	mJ
V_{ESD}	Electrostatic discharge (Human Body Model: R=1.5KΩ; C=100pF) – Input – Status – STAT_DIS – Output – V_{CC}	4000 4000 4000 5000 5000	V V V V V
V_{ESD}	Charge device model (CDM-AEC-Q100-011)	750	V

Table 4.   Absolute maximum ratings (continued)

Symbol	Parameter	Value	Unit
T_j	Junction operating temperature	-40 to 150	°C
T_{stg}	Storage temperature	- 55 to 150	°C

2.2   Thermal data

Table 5.   Thermal data

Symbol	Parameter	Max. value	Unit
$R_{thj-case}$	Thermal resistance junction-case (with one channel on)	8	°C/W
$R_{thj-amb}$	Thermal resistance junction-ambient	See *Figure 32.*	°C/W

2.3   Electrical characteristics

$8V<V_{CC}<36V$; $-40°C< T_j <150°C$, unless otherwise specified

Table 6.   Power section

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{CC}	Operating supply voltage		4.5	13	36	V
V_{USD}	Undervoltage shutdown			3.5	4.5	V
$V_{USDhyst}$	Undervoltage shutdown hysteresis			0.5		V
R_{ON}	On-state resistance[1]	I_{OUT}=1A; T_j=25°C I_{OUT}=1A; T_j=150°C I_{OUT}=1A; V_{CC}=5V; T_j=25°C			160 320 210	mΩ mΩ mΩ
V_{clamp}	Clamp voltage	I_S=20 mA	41	46	52	V
I_S	Supply current	Off-state; V_{CC}=13V; V_{IN}=V_{OUT}=0V; T_j=25°C On-state; V_{IN}=5V; V_{CC}=13V; I_{OUT}=0A		2[2] 8	5[2] 14	μA mA
$I_{L(off1)}$	Off-state output current[1]	V_{IN}=V_{OUT}=0V; V_{CC}=13V; T_j=25°C V_{IN}=V_{OUT}=0V; V_{CC}=13V; T_j=125°C	0 0	0.01	3 5	μA μA
$I_{L(off2)}$	Off-state output current[1]	V_{IN}=0V; V_{OUT}=4V	-75		0	μA
V_F	Output - V_{CC} diode voltage[1]	$-I_{OUT}$=0.6A; T_j=150°C			0.7	V

1. For each channel.

2. PowerMOS leakage included.

Table 7. Switching (V_{CC} = 13V; T_j = 25°C)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	R_L=13Ω (see *Figure 6.*)		15		μs
$t_{d(off)}$	Turn-off delay time	R_L=13Ω (see *Figure 6.*)		15		μs
$dV_{OUT}/dt_{(on)}$	Turn-on voltage slope	R_L=13Ω		See *Figure 6.*		V/μs
$dV_{OUT}/dt_{(off)}$	Turn-off voltage slope	R_L=13Ω		See *Figure 6.*		V/μs
W_{ON}	Switching energy losses during t_{won}	R_L=13Ω (see *Figure 6.*)		0.05		mJ
W_{OFF}	Switching energy losses during t_{woff}	R_L=13Ω (see *Figure 6.*)		0.03		mJ

Table 8. Status pin (V_{SD}=0)

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
V_{STAT}	Status low output voltage	I_{STAT}= 1.6 mA, V_{SD}=0V			0.5	V
I_{LSTAT}	Status leakage current	Normal operation or V_{SD}=5V, V_{STAT}= 5V			10	μA
C_{STAT}	Status pin input capacitance	Normal operation or V_{SD}=5V, V_{STAT}= 5V			100	pF
V_{SCL}	Status clamp voltage	I_{STAT}= 1mA I_{STAT}= -1mA	5.5 	 -0.7	7 	V V

Table 9. Protection[1]

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{limH}	DC Short circuit current	V_{CC}=13V 5V<V_{CC}<36V	3.8 	5.4 	7.5 7.5	A A
I_{limL}	Short circuit current during thermal cycling	V_{CC}=13V T_R<T_j<T_{TSD}		2		A
T_{TSD}	Shutdown temperature		150	175	200	°C
T_R	Reset temperature		T_{RS} + 1	T_{RS} + 5		°C
T_{RS}	Thermal reset of STATUS		135			°C
T_{HYST}	Thermal hysteresis (T_{TSD}-T_R)			7		°C
t_{SDL}	Status delay in overload conditions	T_j>T_{TSD} (See *Figure 4.*)			20	μs

Table 9. Protection[1] (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{DEMAG}	Turn-off output voltage clamp	I_{OUT}=1A; V_{IN}=0; L=20mH	V_{CC}-41	V_{CC}-46	V_{CC}-52	V
V_{ON}	Output voltage drop limitation	I_{OUT}=0.03A (see *Figure 5.*) T_j= -40°C...+150°C		25		mV

1. To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper software strategy. If the device is subjected to abnormal conditions, this software must limit the duration and number of activation cycles

Table 10. Open-load detection

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
I_{OL}	Open-load on-state detection threshold	V_{IN} = 5V ,8V<V_{CC}<18V	10	See *Figure 18.*	40	mA
$t_{DOL(on)}$	Open-load on-state detection delay	I_{OUT} = 0A, V_{CC}=13V (See *Figure 4.*)			200	μs
t_{POL}	Delay between INPUT falling edge and STATUS rising edge in Open-load condition	I_{OUT} = 0A (See *Figure 4.*)	200	500	1000	μs
V_{OL}	Open-load OFF-state voltage detection threshold	V_{IN} = 0V, 8V<V_{CC}<16V	2	See *Figure 19.*	4	V
t_{DSTKON}	Output short circuit to V_{cc} detection delay at turn-off	(See *Figure 4.*)	180		t_{POL}	μs

Table 11. Logic input

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_{IL}	Input low level				0.9	V
I_{IL}	Low level input current	V_{IN} = 0.9V	1			μA
V_{IH}	Input high level		2.1			V
I_{IH}	High level input current	V_{IN} = 2.1V			10	μA
$V_{I(hyst)}$	Input hysteresis voltage		0.25			V
V_{ICL}	Input clamp voltage	I_{IN} = 1mA I_{IN} = -1mA	5.5	-0.7	7	V V
V_{SDL}	STAT_DIS low level voltage				0.9	V
I_{SDL}	Low level STAT_DIS current	V_{SD}=0.9V	1			μA
V_{SDH}	STAT_DIS high level voltage		2.1			V

Table 11.   Logic input (continued)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SDH}	High level STAT_DIS current	V_{SD}=2.1V			10	μA
$V_{SD(hyst)}$	STAT_DIS hysteresis voltage		0.25			V
V_{SDCL}	STAT_DIS clamp voltage	I_{SD}=1mA I_{SD}=-1mA	5.5	-0.7	7	V V

Figure 4.   Status timings
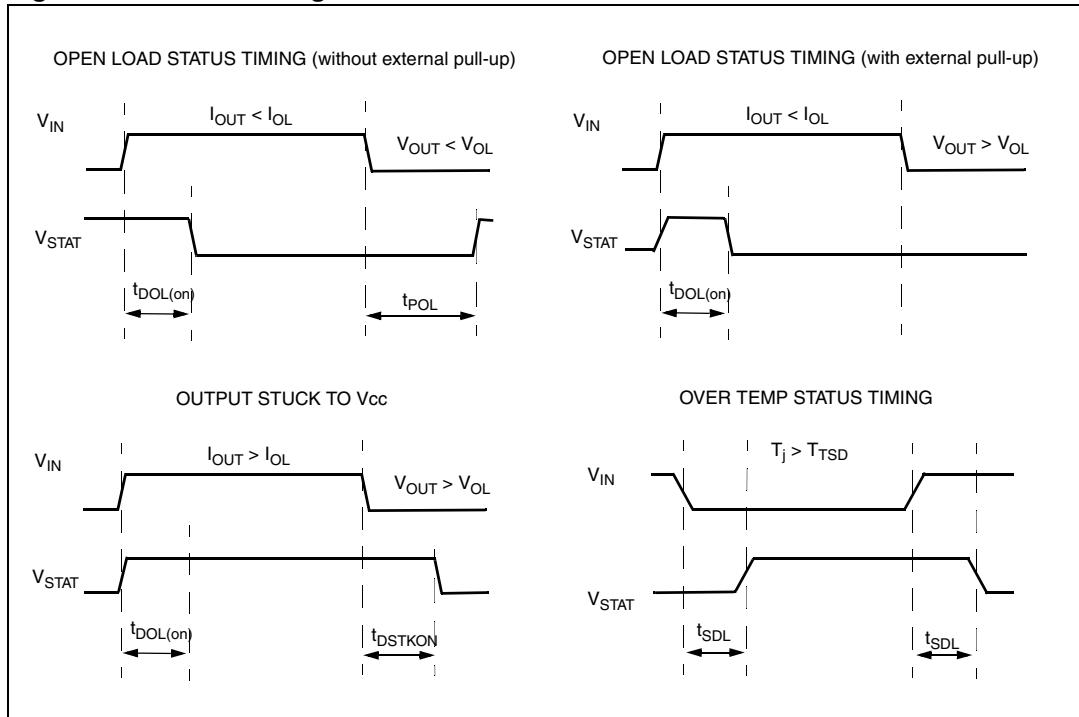
Figure 5.   Output voltage drop limitation
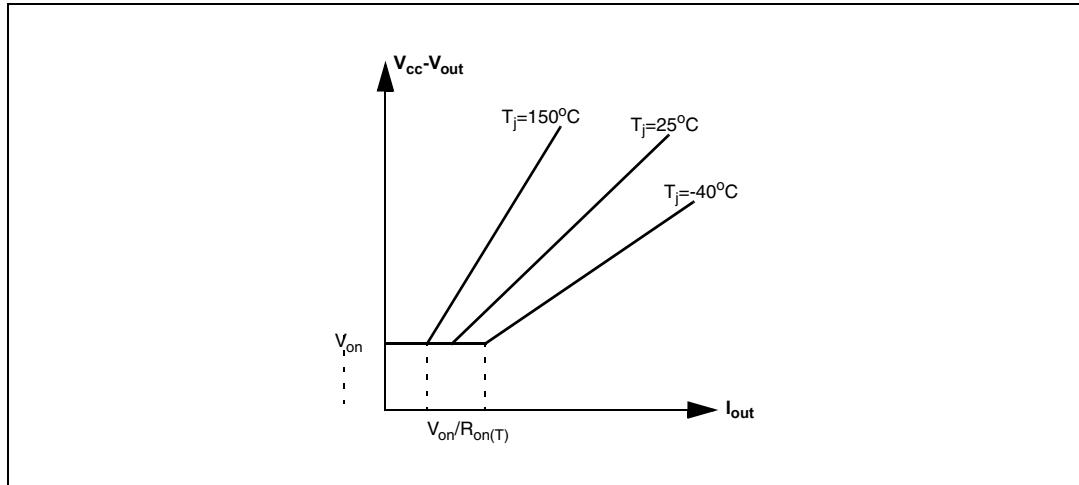
Table 12.   Truth table

Conditions	INPUTn	OUTPUTn	STATUSn (V_{SD}=0V)[1]
Normal operation	L H	L H	H H
Current limitation	L H	L X	H H
Overtemperature	L H	L L	H L
Undervoltage	L H	L L	X X
Output voltage > V_{OL}	L H	H H	L[2] H
Output current < I_{OL}	L H	L H	H[3] L

1. If the V_{SD} is high, the STATUS pin is in a high impedance.

2. The STATUS pin is low with a delay equal to t_{DSTKON} after INPUT falling edge.

3. The STATUS pin becomes high with a delay equal to t_{POL} after INPUT falling edge.

Figure 6.   Switching characteristics
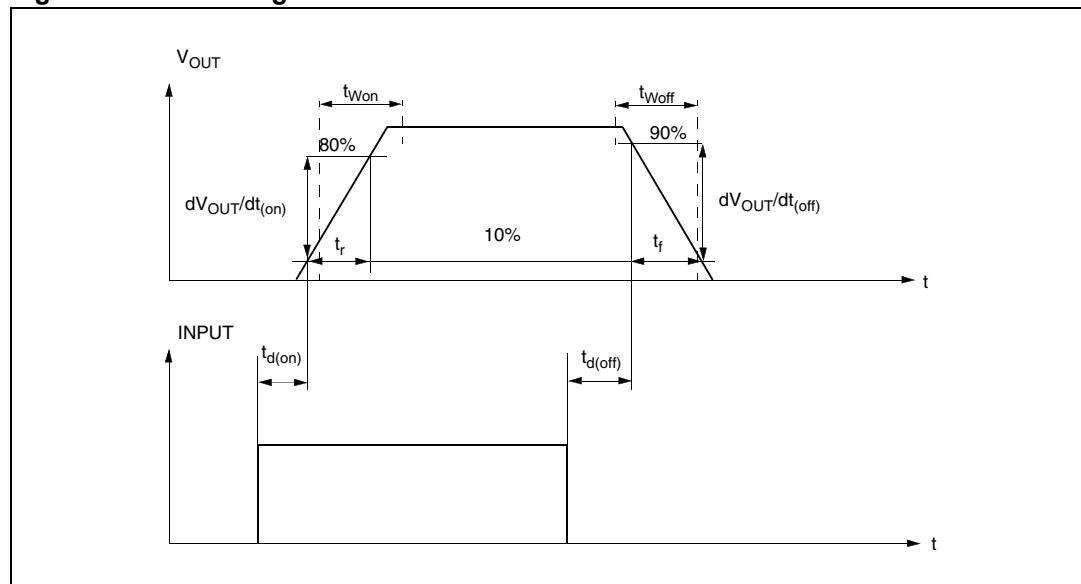
Table 13.   Electrical transient requirements (part 1/3)

ISO 7637-2: 2004(E) Test pulse	Test levels[1]		Number of pulses or test times	Burst cycle/pulse repetition time		Delays and Impedance
	III	IV				
1	-75 V	-100 V	5000 pulses	0.5 s	5 s	2 ms, 10 Ω
2a	+37 V	+50 V	5000 pulses	0.2 s	5 s	50 μs, 2 Ω
3a	-100 V	-150 V	1h	90 ms	100 ms	0.1 μs, 50 Ω
3b	+75 V	+100 V	1h	90 ms	100 ms	0.1 μs, 50 Ω
4	-6 V	-7 V	1 pulse			100 ms, 0.01 Ω
5b[1]	+65 V	+87 V	1 pulse			400 ms, 2 Ω

1. Valid in case of external load dump clamp: 40V maximum referred to ground.

Table 14.   Electrical transient requirements (part 2/3)

ISO 7637-2: 2004(E) Test pulse	Test level results[1]	
	III	IV
1	C	C
2a	C	C
3a	C	C
3b	C	C
4	C	C
5b[2]	C	C

1. The above test levels must be considered referred to V_{CC} = 13.5V except for pulse 5b

2. Valid in case of external load dump clamp: 40V maximum referred to ground.

Table 15.   Electrical transient requirements (part 3/3)

Class	Contents
C	All functions of the device are performed as designed after exposure to disturbance.
E	One or more functions of the device are not performed as designed after exposure to disturbance and cannot be returned to proper operation without replacing the device.

2.4 Electrical characteristics curves

Figure 7. Off-state output current
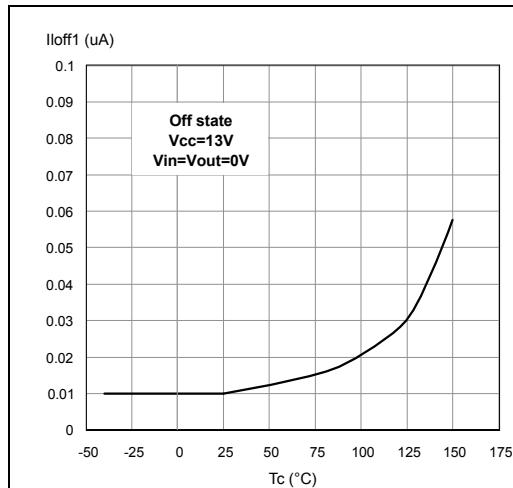


Figure 8. High level input current
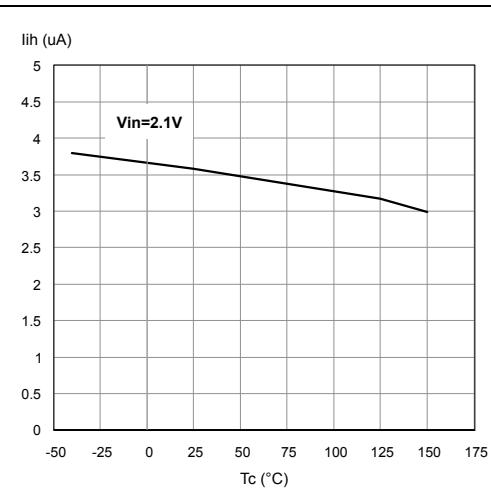

Figure 9. Input clamp voltage
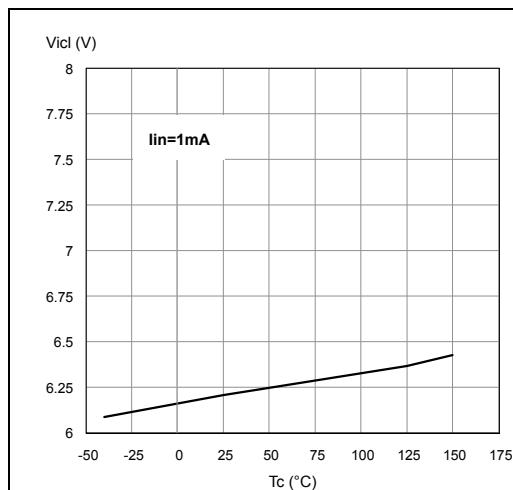

Figure 10. Input low level voltage
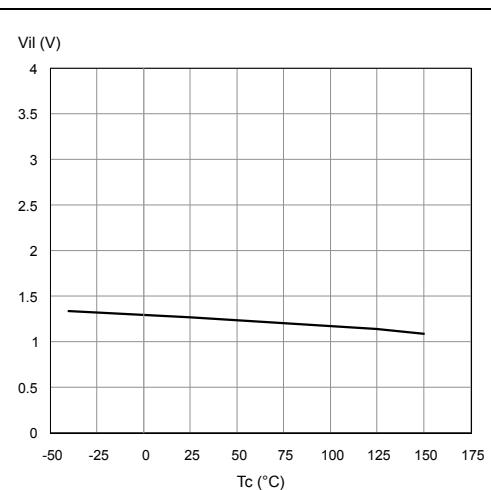
Figure 11. Input high level voltage
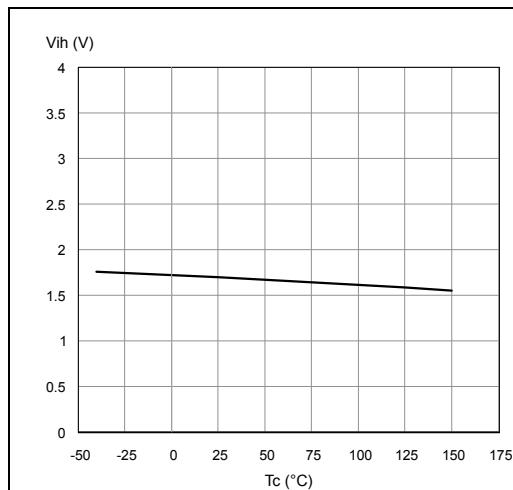
Figure 12. Input hysteresis voltage
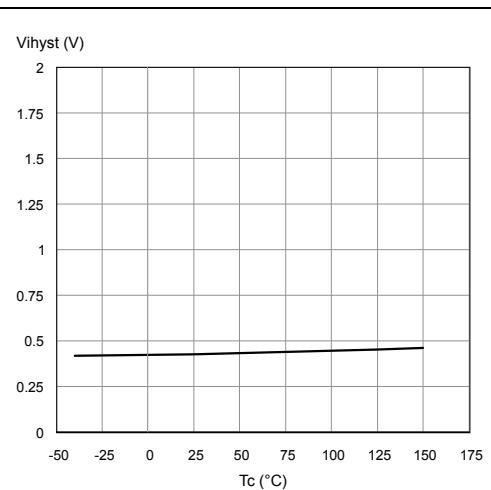
**Figure 13.   Status low output voltage**
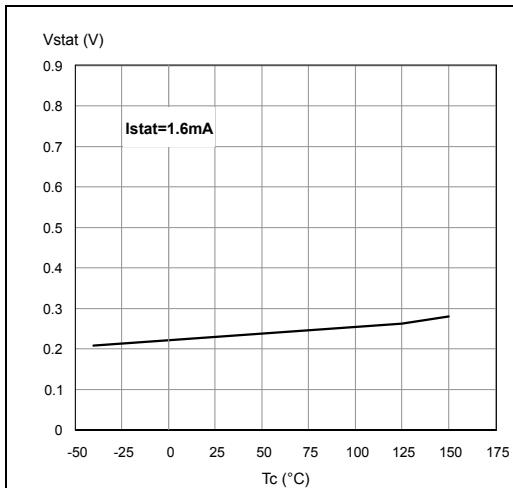
Figure 14.   Status leakage current
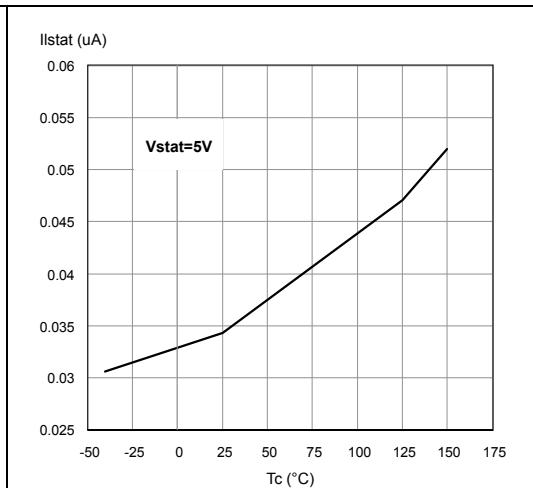
Figure 15.   On-state resistance vs T$_{case}$
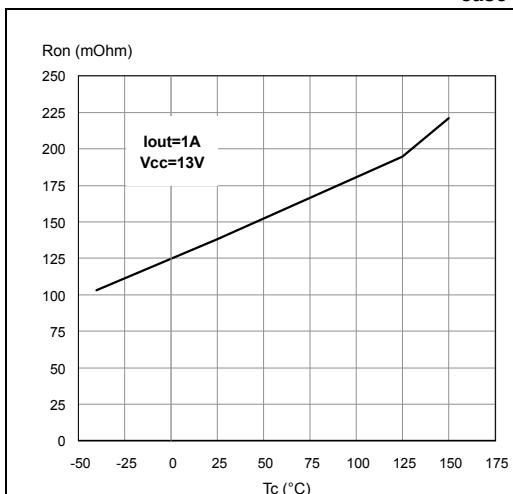

**Figure 16.   On-state resistance vs V$_{CC}$**
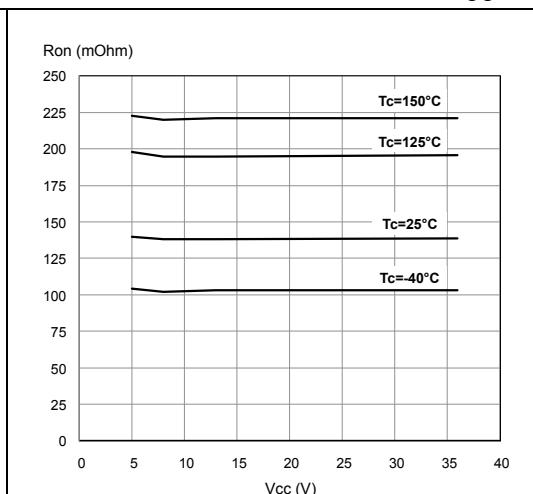
**Figure 17.   Status clamp voltage**
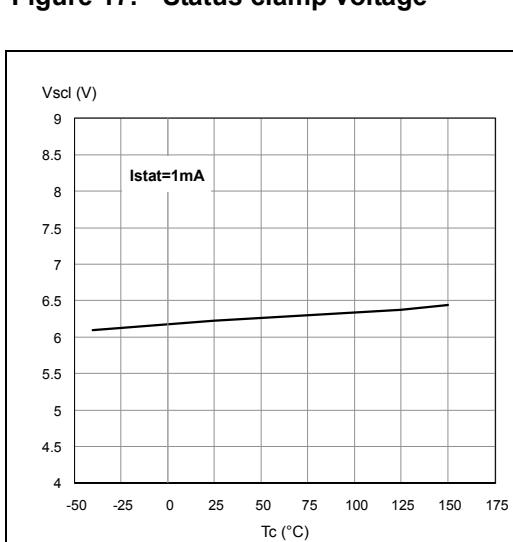
**Figure 18.   Open-load on-state detection threshold**
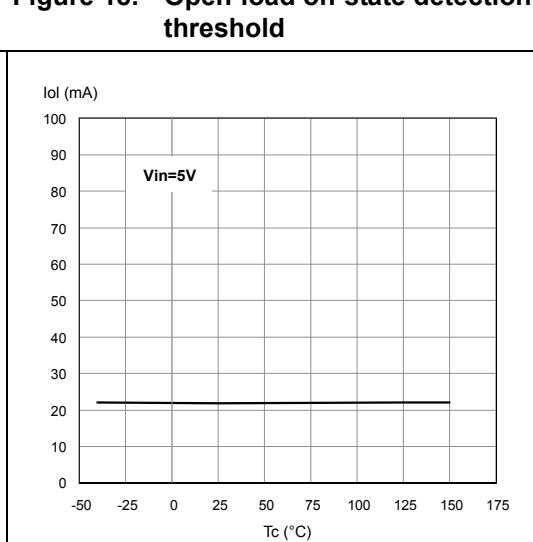
**Figure 19. Open-load off-state voltage detection threshold**
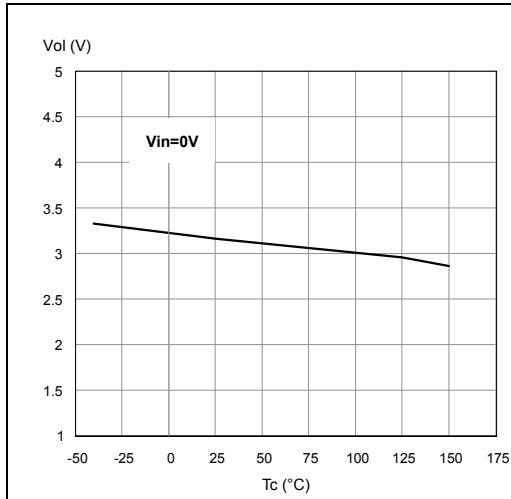
Figure 20. Undervoltage shutdown
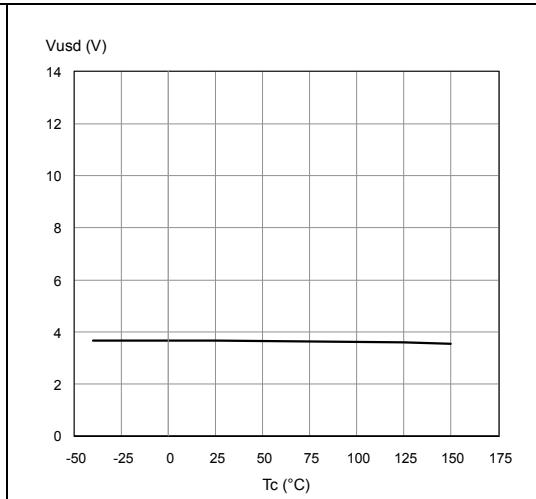
**Figure 21. Turn-on voltage slope**
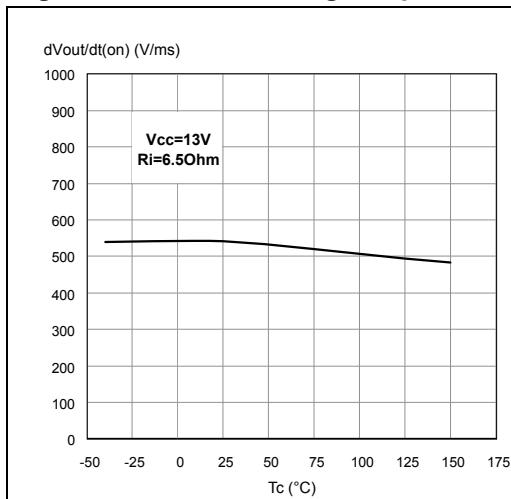

Figure 22. I_{LIMH} vs T_{case}
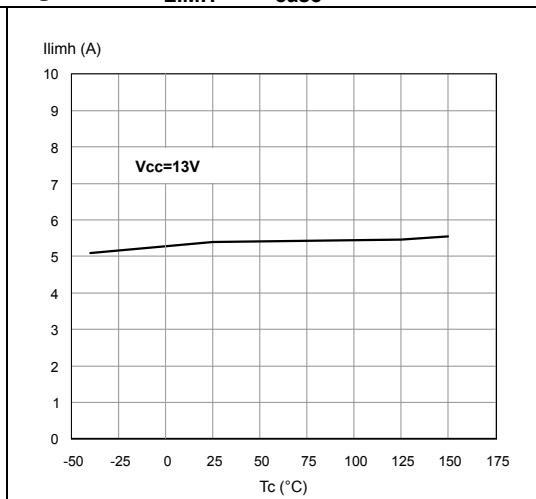

Figure 23. Turn-off voltage slope
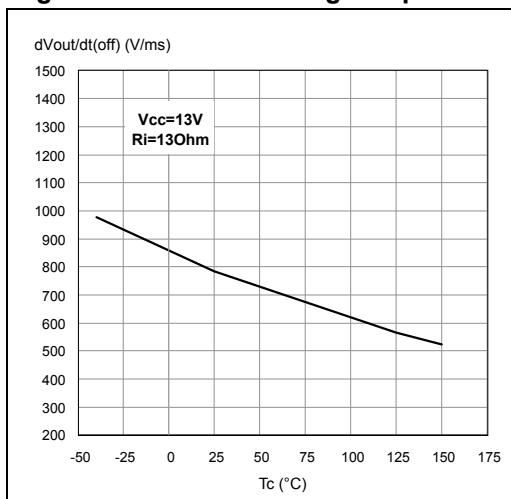

Figure 24. High-level STAT_DIS voltage
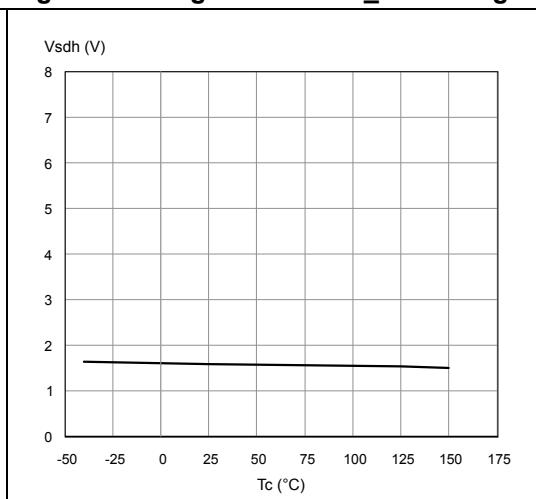
**Figure 25. STAT_DIS clamp voltage**
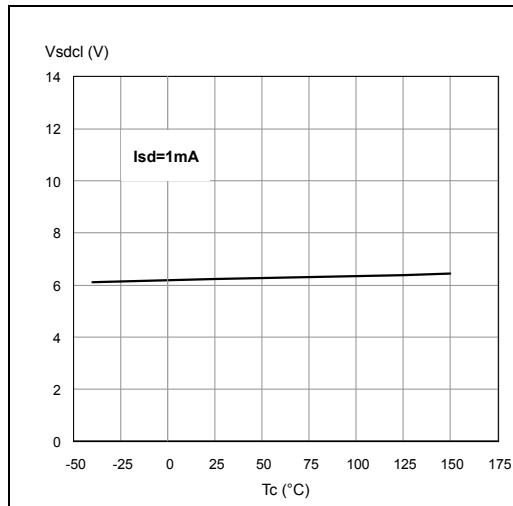
Figure 26. Low level STAT_DIS voltage
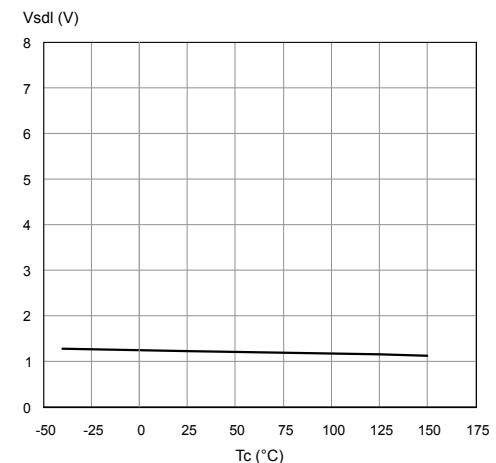
3 Application information

Figure 27. Application schematic
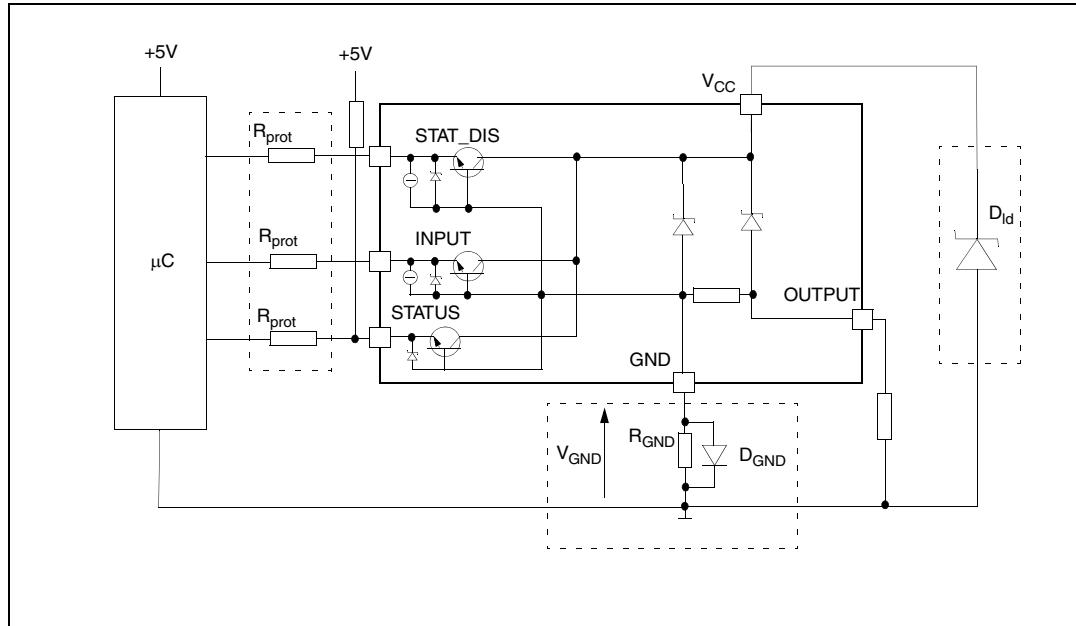
Note: Channels 2, 3 and 4 have the same internal circuit as channel 1.

3.1 GND protection network against reverse battery

3.1.1 Solution 1: resistor in the ground line (R_{GND} only).

This solution can be used with any type of load.

The following is an indication on how to dimension the R_{GND} resistor.

1. $R_{GND} \leq 600mV / (I_{S(on)max})$.
2. $R_{GND} \geq (-V_{CC}) / (-I_{GND})$

where $-I_{GND}$ is the DC reverse ground pin current and can be found in the absolute maximum rating section of the device datasheet.

Power dissipation in R_{GND} (when $V_{CC}<0$: during reverse battery situations) is:

$P_D = (-V_{CC})^2 / R_{GND}$

This resistor can be shared amongst several different HSDs. Please note that the value of this resistor should be calculated with formula (1) where $I_{S(on)max}$ becomes the sum of the maximum on-state currents of the different devices.

Please note that if the microprocessor ground is not shared by the device ground then the R_{GND} will produce a shift ($I_{S(on)max} * R_{GND}$) in the input thresholds and the status output values. This shift will vary depending on how many devices are ON in the case of several high side drivers sharing the same R_{GND}.

If the calculated power dissipation leads to a large resistor or several devices have to share the same resistor then ST suggests that Solution 2 is used(see below).

3.1.2 Solution 2: a diode (D_{GND}) in the ground line.

A resistor (R_{GND}=1kΩ) should be inserted in parallel with D_{GND} if the device drives an inductive load.

This small signal diode can be safely shared amongst several different HSDs. Also in this case, the presence of the ground network will produce a shift (~600mV) in the input threshold and in the status output values if the microprocessor ground is not common with the device ground. This shift will not vary if more than one HSD shares the same diode/resistor network.

3.2 Load dump protection

D_{ld} is necessary (Voltage Transient Suppressor) if the load dump peak voltage exceeds to V_{CC} max DC rating. The same applies if the device is subject to transients on the V_{CC} line that are greater than the ones shown in the ISO T/R 7637/1 table.

3.3 Microcontroller I/Os protection

If a ground protection network is used and negative transients are present on the V_{CC} line, the control pins will be pulled negative. ST suggests the insertion of resistors (R_{prot}) in the lines to prevent the μC I/Os pins from latching up.

The values of these resistors are a compromise between the leakage current of μC and the current required by the HSD I/Os (input levels compatibility) with the latch-up limit of the μC I/Os.

$-V_{CCpeak}/I_{latchup} \leq R_{prot} \leq (V_{OH\mu C}-V_{IH}-V_{GND}) / I_{IHmax}$

Calculation example:

For V_{CCpeak}= - 100V and $I_{latchup} \geq$ 20mA; $V_{OH\mu C} \geq$ 4.5V

$5k\Omega \leq R_{prot} \leq 65k\Omega$.

Recommended R_{prot} value is 10kΩ.

3.4 Open-load detection in off-state

Off-state open-load detection requires an external pull-up resistor (R_{PU}) connected between the OUTPUT pin and a positive supply voltage (V_{PU}) like the +5V line used to supply the microprocessor.

The external resistor has to be selected according to the following requirements:

1. No false open-load indication when load is connected: in this case we have to avoid V_{OUT} to be higher than V_{Olmin}; this results in the following condition:

    $V_{OUT}=(V_{PU}/(R_L+R_{PU}))R_L < V_{Olmin}.$

2. No misdetection when the load is disconnected: in this case the V_{OUT} has to be higher than V_{OLmax}; this results in the following condition:

    $R_{PU} < (V_{PU} - V_{OLmax})/I_{L(off2)}.$

Because $I_{s(OFF)}$ may significantly increase if V_{out} is pulled high (up to several mA), the pull-up resistor R_{PU} should be connected to a supply that is switched OFF when the module is in standby.

The values of V_{OLmin}, V_{OLmax} and $I_{L(off2)}$ are available in the Electrical characteristics section.

Figure 28. Open-load detection in off-state
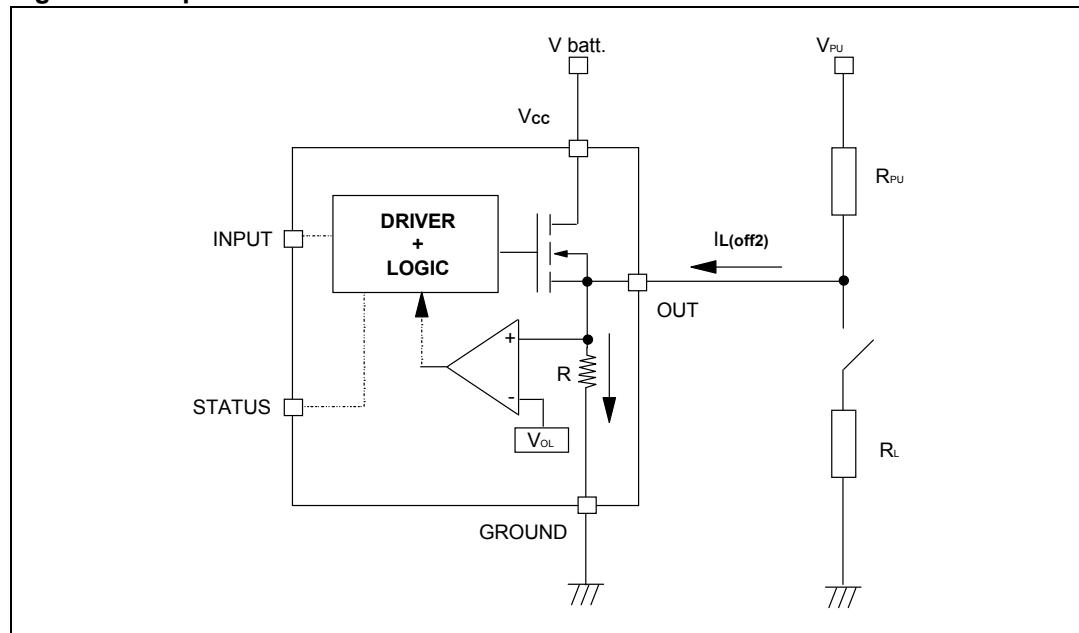
Figure 29. Waveforms
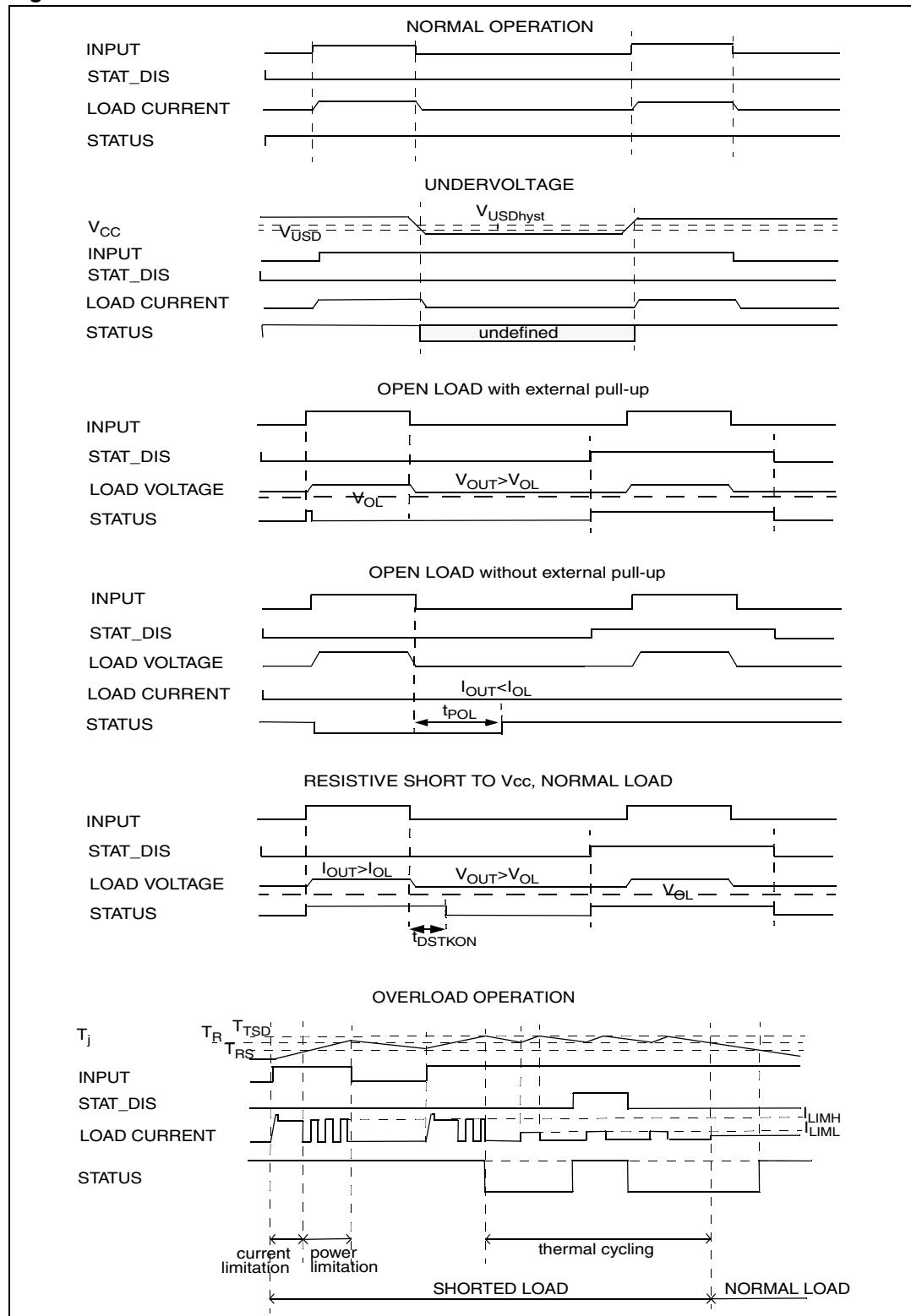
3.5 Maximum demagnetization energy (V_{CC} = 13.5V)

Figure 30. Maximum turn-off current versus inductance (for each channel)

A: T_{jstart} = 150°C single pulse

B: T_{jstart} = 100°C repetitive pulse

C: T_{jstart} = 125°C repetitive pulse
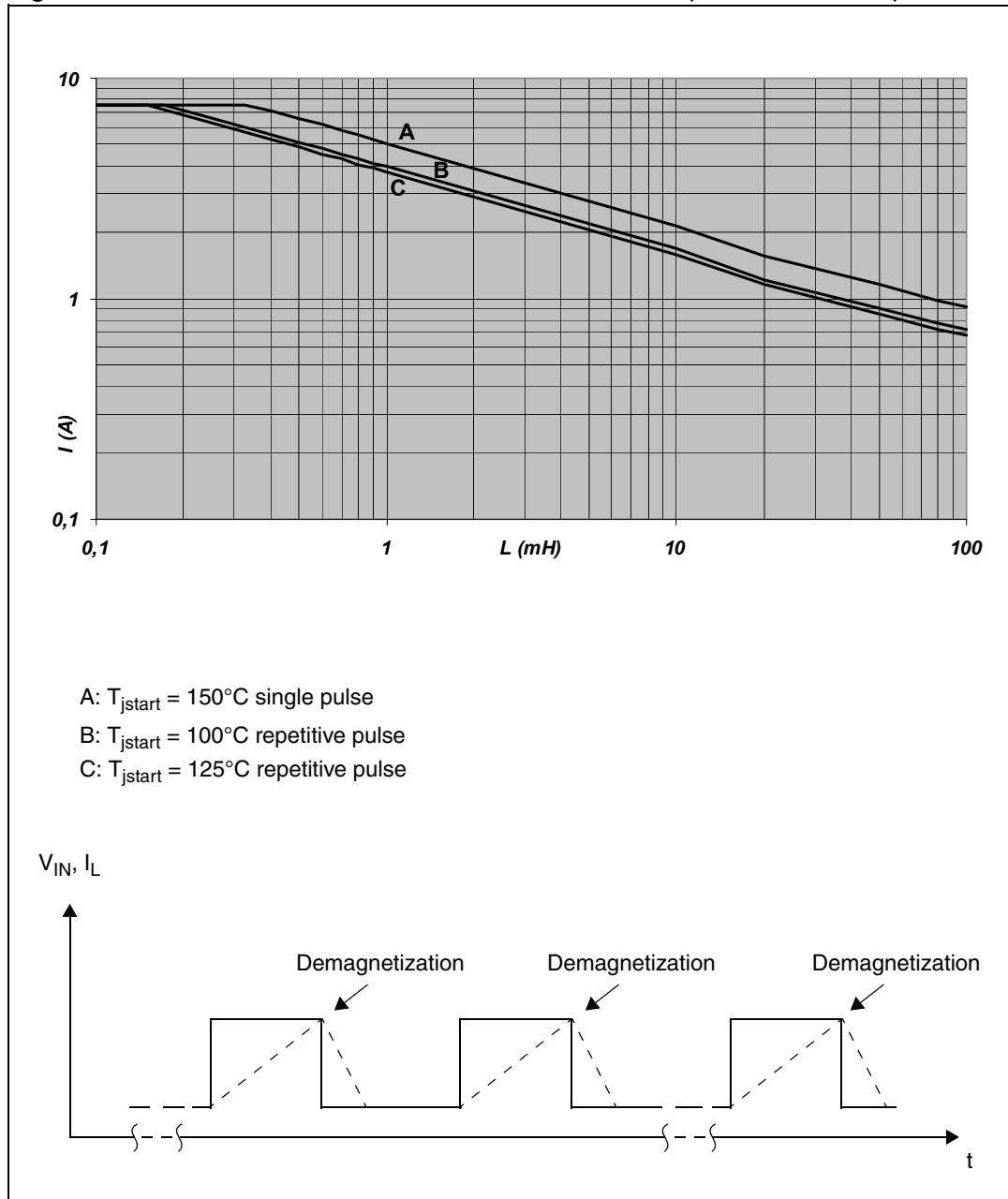
Note: *Values are generated with $R_L = 0\Omega$*

In case of repetitive pulses, T_{jstart} (at beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves A and B.

4 Package and PC board thermal data

4.1 PowerSSO-24 thermal data

Figure 31. PowerSSO-24 PC board
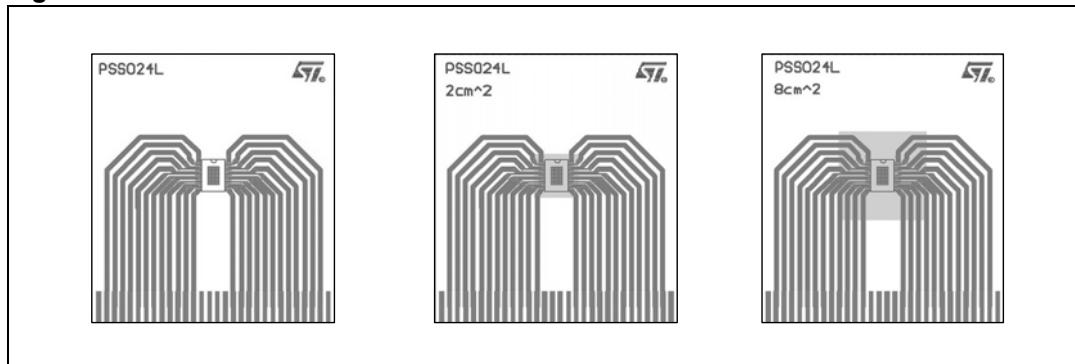
Note: *Layout condition of R_{th} and Z_{th} measurements (PCB: double layer, thermal vias, FR4 area= 77mm x 86mm, PCB thickness=1.6mm, Cu thickness=70mm (front and back side), copper areas: from minimum pad lay-out to 8cm^2).*

Figure 32. $R_{thj\text{-}amb}$ vs PCB copper area in open box free air condition (one channel ON)
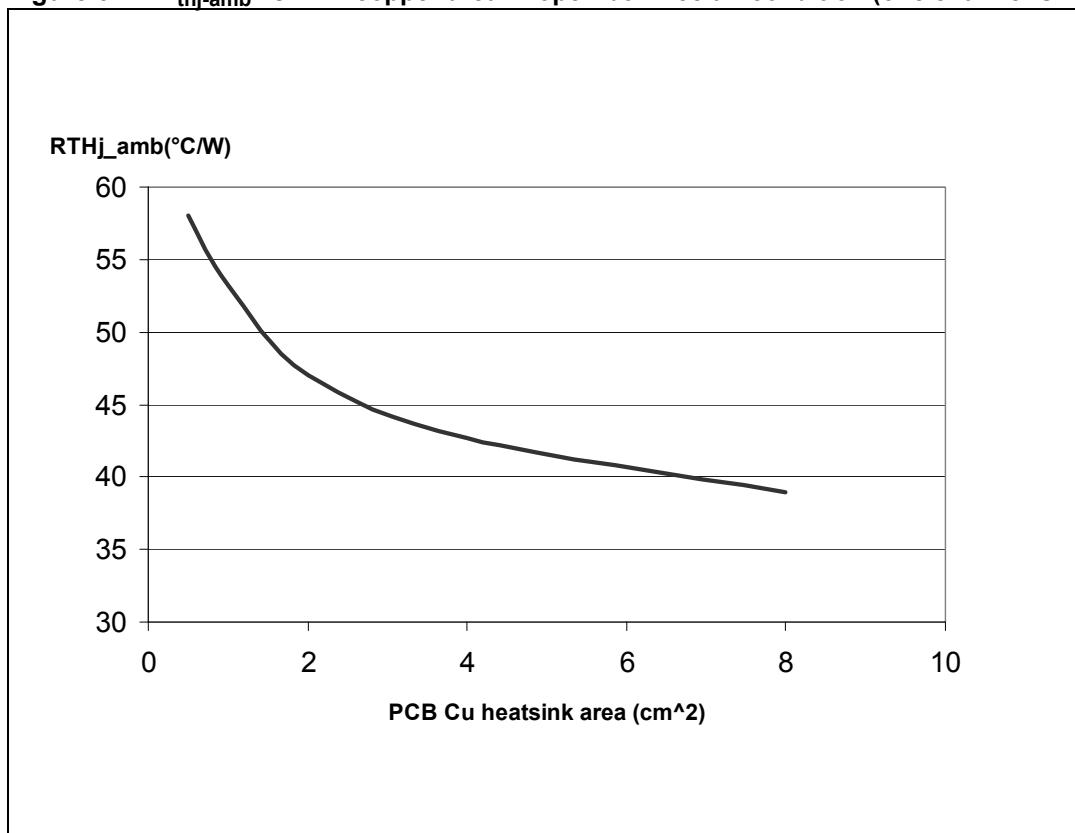
Figure 33. PowerSSO-24 thermal impedance junction ambient single pulse (one channel on)
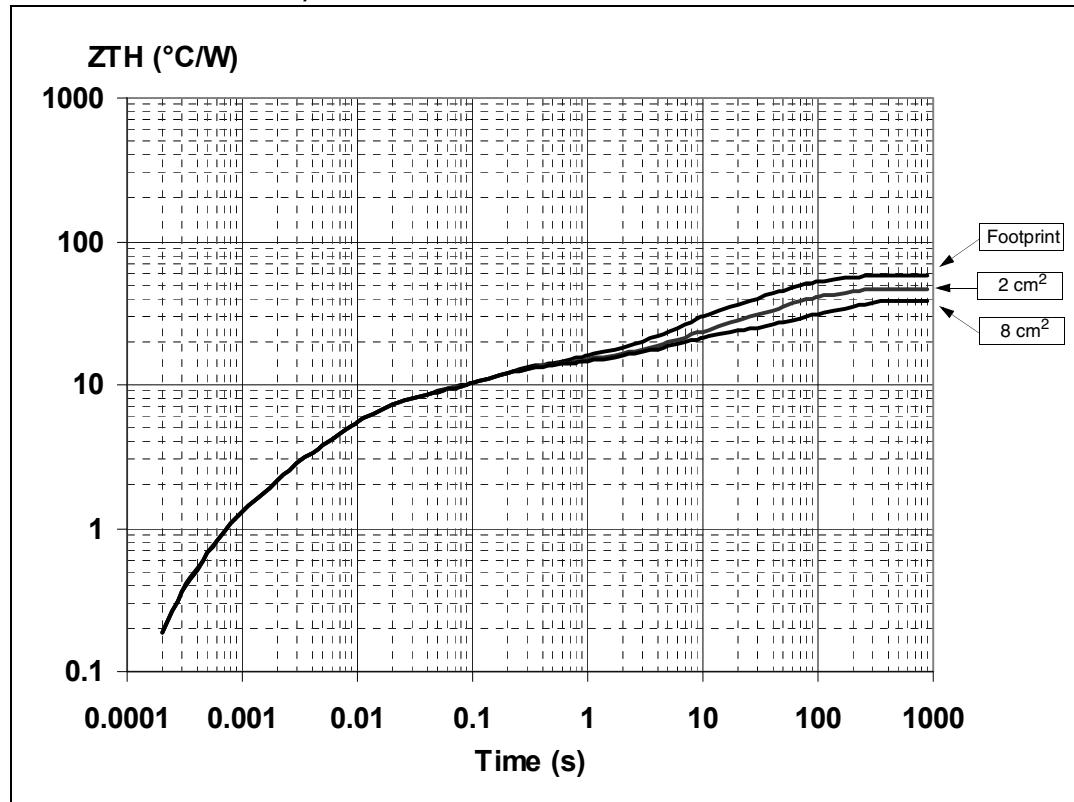
Figure 34. Thermal fitting model of a double channel HSD in PowerSSO-24[1]
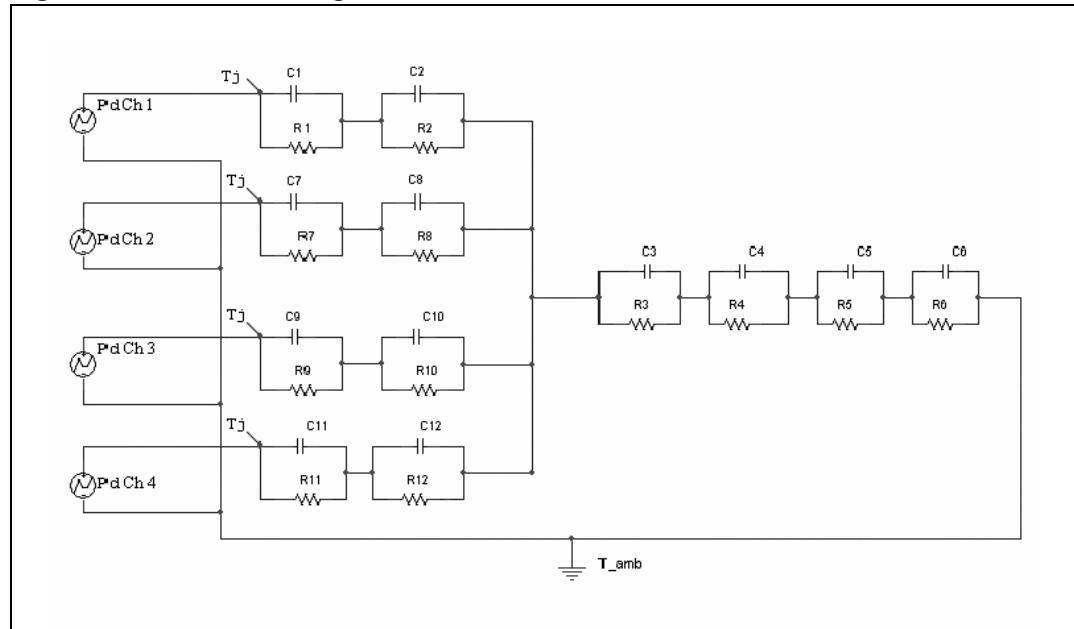
1. The fitting model is a semplified thermal tool and is valid for transient evolutions where the embedded protections (power limitation or thermal cycling during thermal shutdown) are not triggered

Equation 1: pulse calculation formula:

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where $\delta = t_P/T$

Table 16.   Thermal parameters

Area/island (cm^2)	Footprint	2	8
R1 = R7 = R9 = R11 (°C/W)	1.2		
R2 = R8 = R10 = R12 (°C/W)	6		
R3 (°C/W)	6		
R4 (°C/W)	7.7		
R5 (°C/W)	9	9	8
R6 (°C/W)	28	17	10
C1 = C7 = C9 = C11 (W.s/°C)	0.0008		
C2 = C8 = C10 = C12 (W.s/°C)	0.0016		
C3 (W.s/°C)	0.025		
C4 (W.s/°C)	0.75		
C5 (W.s/°C)	1	4	9
C6 (W.s/°C)	2.2	5	17

5 Package and packing information

5.1 ECOPACK® packages

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com.

ECOPACK® is an ST trademark.

5.2 PowerSSO-24™ mechanical data

Figure 35. PowerSSO-24™ package dimensions
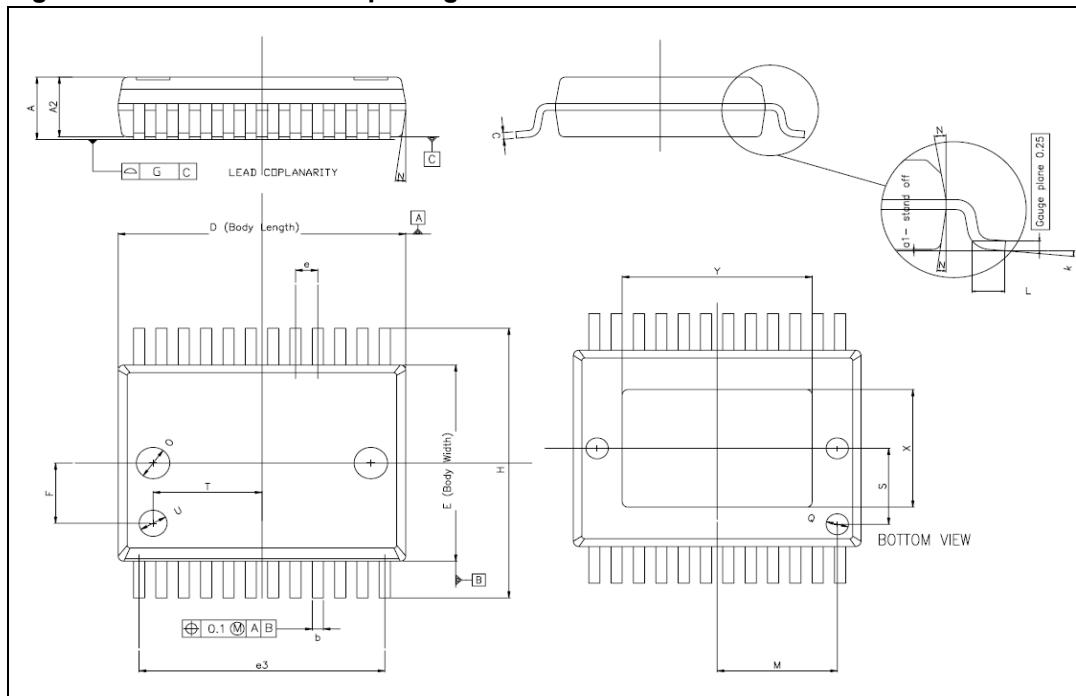
Table 17.   PowerSSO-24™ mechanical data

Symbol	Millimeters		
	Min	**Typ**	**Max**
A			2.45
A2	2.15		2.35
a1	0		0.1
b	0.33		0.51
c	0.23		0.32
D	10.10		10.50
E	7.4		7.6
e		0.8	
e3		8.8	
F		2.3	
G			0.1
H	10.1		10.5
h			0.4
k	0°		8°
L	0.55		0.85
O		1.2	
Q		0.8	
S		2.9	
T		3.65	
U		1.0	
N			10°
X	4.1		4.7
Y	6.5		7.1

5.3   Packing information

Figure 36.   PowerSSO-24 tube shipment (no suffix)

Base Q.ty	49
Bulk Q.ty	1225
Tube length (± 0.5)	532
A	3.5
B	13.8
C (± 0.1)	0.6

All dimensions are in mm.
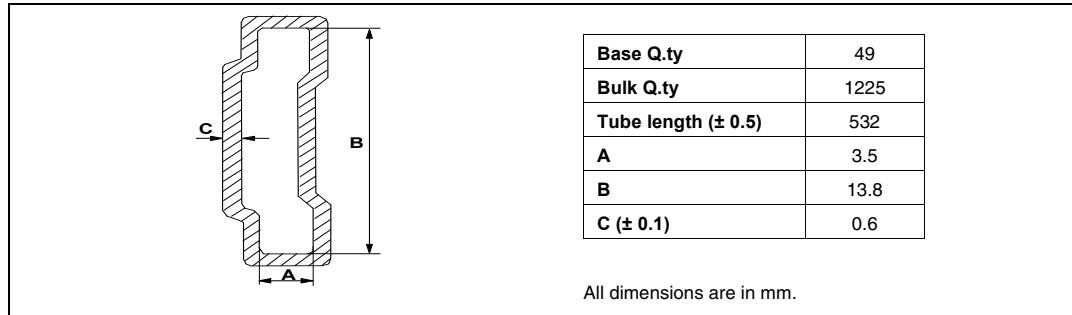
Figure 37.   Tape and reel shipment (suffix "TR")

Reel dimensions

Base Q.ty	1000
Bulk Q.ty	1000
A (max)	330
B (min)	1.5
C (± 0.2)	13
F	20.2
G (+ 2 / -0)	24.4
N (min)	100
T (max)	30.4

All dimensions are in mm.

TAPE DIMENSIONS

According to Electronic Industries Association
(EIA) Standard 481 rev. A, Feb 1986

Tape width	W	24
Tape Hole Spacing	P0 (± 0.1)	4
Component Spacing	P	12
Hole Diameter	D (± 0.05)	1.55
Hole Diameter	D1 (min)	1.5
Hole Position	F (± 0.1)	11.5
Compartment Depth	K (max)	2.85
Hole Spacing	P1 (± 0.1)	2

All dimensions are in mm.

6   Revision history

Table 18.   Document revision history

Date	Revision	Changes
8-Jan-2004	1	Initial release.
20-Jan-2006	2	Major general update
15-Mar-2007	3	Reformatted and restructured. Contents, List of tables and List of figures added. *Section 3.5: Maximum demagnetization energy (VCC = 13.5V)* added. *Section 5.1: ECOPACK® packages* information added. New disclaimer added.
01-Jun-2007	4	*Table 4: Absolute maximum ratings*: E$_{MAX}$ entries updated. *Table 13: Electrical transient requirements (part 1/3)* :Test level values III and IV for test pulse 5b and notes updated *Figure 34: Thermal fitting model of a double channel HSD in PowerSSO-24(1)* note added
22-Jun-2009	5	*Table 17: PowerSSO-24™ mechanical data*: – Deleted A (min) value – Changed A (max) value from 2.47 to 2.45 – Changed A2 (max) value from 2.40 to 2.35 – Changed a1 (max) value from 0.075 to 0.1 Added F and k rows
23-Jul-2009	6	Updated *Figure 35: PowerSSO-24™ package dimensions*. Updated *Table 17: PowerSSO-24™ mechanical data*: – Deleted G1 row – Added O, Q, S, T and U rows
23-Sep-2013	7	Updated Disclaimer

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